Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/785,182	WANG ET AL.	
Examiner	Art Unit	
Anabel M. Ton	2875	

	SEAR	CHED	
Class	Subclass	Date	Examiner
362	600	12/10/2005	AT
	561		
	290		
	339		
	28		
	97		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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